STP6N90K5



N-channel 900 V, 0.91 Ω typ., 6 A MDmesh™ K5 Power MOSFET in a TO-220 package

Datasheet - production data

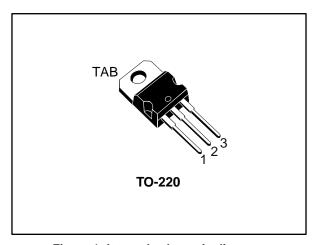
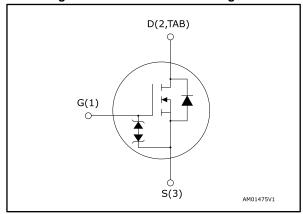


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	
STP6N90K5	900 V	1.10 Ω	6 A	

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STP6N90K5	6N90K5	TO-220	Tube

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STP6N90K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	± 30	V
I_D	Drain current (continuous) at T _C = 25 °C	6	Α
I _D	Drain current (continuous) at T _C = 100 °C	4	Α
I _D ⁽¹⁾	Drain current (pulsed)	24	Α
P _{TOT}	Total dissipation at T _C = 25 °C	110	W
dv/dt (2)	Peak diode recovery voltage slope	4.5	
dv/dt (3)	MOSFET dv/dt ruggedness	50 V	
Tj	Operating junction temperature range	FF to 150	°C
T _{stg}	Storage temperature range	- 55 to 150	,

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	1.14	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	2	А
Eas	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} , V_{DD} = 50 V)	210	mJ



⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \le 6$ A, di/dt ≤ 100 A/µs; VDs peak < V(BR)DSS, VDD = 450 V.

 $^{^{(3)}}V_{DS} \le 720 \text{ V}$

Electrical characteristics STP6N90K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	900			V
	Zava mata valtama duain	$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}$			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}$ $T_{C} = 125 ^{\circ}\text{C}^{(1)}$			50	μΑ
Igss	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DD} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 3 A		0.91	1.10	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	342	1	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	31	1	pF
Crss	Reverse transfer capacitance	$V_{GS} = 0 V$	-	1.2	1	pF
C _{o(tr)} (1)	Equivalent capacitance time related	V _{DS} = 0 to 720 V,	-	55	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	V _{GS} = 0 V	-	20	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	6.4	-	Ω
Qg	Total gate charge	V _{DD} = 720 V, I _D = 6 A	-	11	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	2.5	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	7	-	nC

Notes:

⁽¹⁾ Defined by design, not subject to production test.

 $^{^{(1)}}$ $C_{o(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DS}

 $^{^{(2)}}$ Co_(er) is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

Table 7: Switching times

Table 11 Children in State 1							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	V_{DD} = 450 V, I_{D} = 3 A, R_{G} = 4.7 Ω	ı	12.4	1	ns	
tr	Rise time	V _{GS} = 10 V	ı	12.2	1	ns	
t _{d(off)}	Turn-off delay time	(see Figure 14: "Test circuit for resistive load switching times" and	-	30.4	-	ns	
t _f	Fall time	Figure 19: "Switching time waveform")	-	15.5	-	ns	

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		6	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		1		24	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 6 A, V _{GS} = 0 V	-		1.5	V
t _{rr}	Reverse recovery time	I _{SD} = 6 A, di/dt = 100 A/µs,	-	342		ns
Qrr	Reverrse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for	-	3.13		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	18.3		Α
t _{rr}	Reverse recovery time	I _{SD} = 6 A, di/dt = 100 A/µs,	-	536		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	4.42		μC
I _{RRM}	Reverse recovery current		-	16.5		А

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30	-		V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

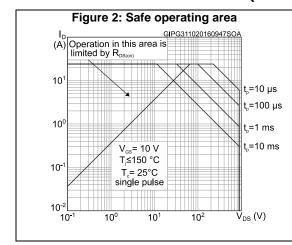
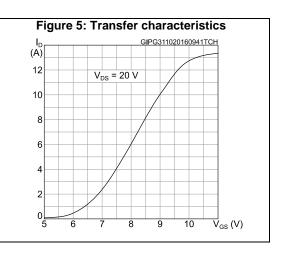
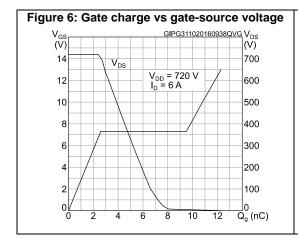
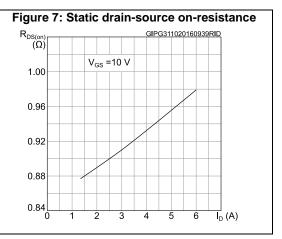


Figure 3: Thermal impedance $K = \frac{CG20930}{\delta = 0.5}$ $\frac{\delta}{\delta} = 0.2$ $\frac{\delta}{\delta} = 0.1$ $\frac{\delta}{\delta} = 0.01$ $\frac{\delta}{\delta} = 0.02$ $\frac{\delta}{\delta} = 0.02$ $\frac{\delta}{\delta} = 0.02$ $\frac{\delta}{\delta} = 0.02$ $\frac{\delta}{\delta} = 0.01$ $\frac{\delta}{\delta} = 0.02$ $\frac{10^2}{10^5} = 10^4 = 10^3 = 10^2 = 10^{-1} = t_p(S)$





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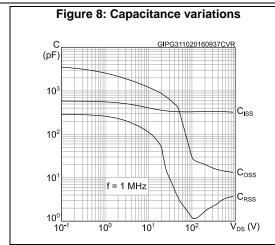


Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG311020160944RON
(norm.)

2.6

V_{GS} = 10 V

2.2

1.8

1.4

1.0

0.6

0.2

-75

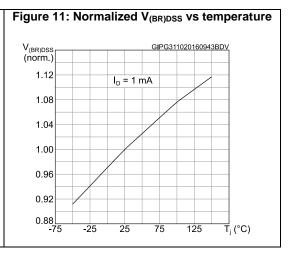
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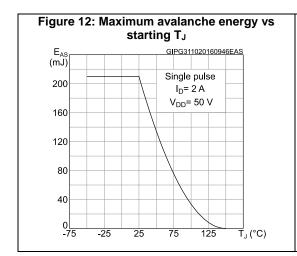
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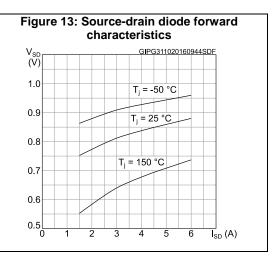
75

125

T_j (°C)







Test circuits STP6N90K5

3 Test circuits

Figure 14: Test circuit for resistive load switching times

Figure 15: Test circuit for gate charge behavior

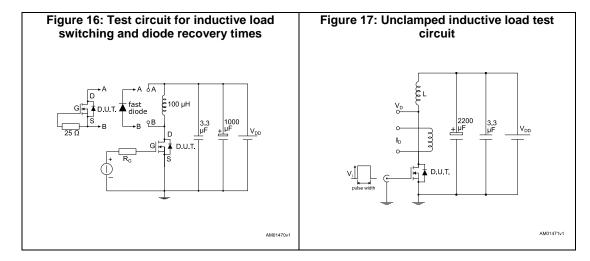
Figure 15: Test circuit for gate charge behavior

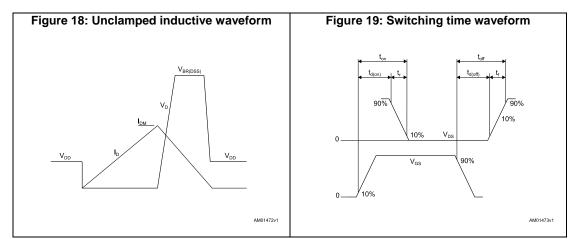
OVDD

RL

Volume width LU.T.

AM01468v1





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STP6N90K5 Package information

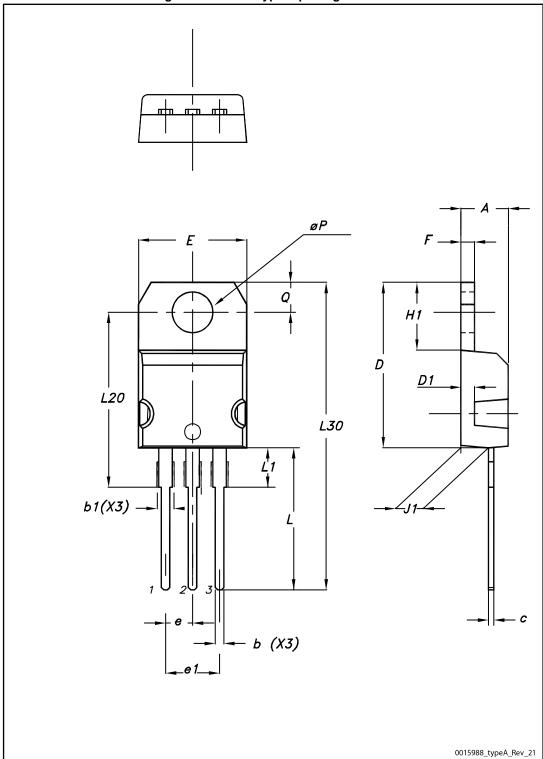
4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



4.1 TO-220 type A package information

Figure 20: TO-220 type A package outline



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Table 10: TO-220 type A mechanical data

mm					
Dim.					
	Min.	Тур.	Max.		
А	4.40		4.60		
b	0.61		0.88		
b1	1.14		1.55		
С	0.48		0.70		
D	15.25		15.75		
D1		1.27			
Е	10.00		10.40		
е	2.40		2.70		
e1	4.95		5.15		
F	1.23		1.32		
H1	6.20		6.60		
J1	2.40		2.72		
L	13.00		14.00		
L1	3.50		3.93		
L20		16.40			
L30		28.90			
øΡ	3.75		3.85		
Q	2.65		2.95		



Revision history STP6N90K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
02-Nov-2016	1	First release.

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